

INFORMATION DISCLOSURE STATEMENT
PTO Form 1449

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Docket Number
SJO919990205US1
501.314US01

Serial Number
10/077036

Applicant(s)
PARKER ET AL.

Filing Date
2/15/02

Group Art Unit
2881

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

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EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS

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Examiner:

Date Considered: 5-16-03

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Ally M. Hunt

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